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Trimmed Offset Voltage:

TLC277 . . . 500 μ V Max at 25°C, $V_{DD} = 5 \text{ V}$

- Input Offset Voltage Drift . . . Typically 0.1 μV/Month, Including the First 30 Days
- Wide Range of Supply Voltages Over Specified Temperature Range:

0°C to 70°C...3 V to 16 V -40°C to 85°C...4 V to 16 V -55°C to 125°C...4 V to 16 V

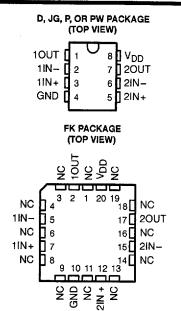
- Single-Supply Operation
- Common-Mode Input Voltage Range Extends Below the Negative Rail (C-Suffix, I-Suffix types)
- Low Noise . . . Typically 25 nV/√Hz at f = 1 kHz
- Output Voltage Range Includes Negative Rail
- High Input impedance . . . 10¹² Ω Typ
- ESD-Protection Circuitry
- Small-Outline Package Option Also Available in Tape and Reel
- Designed-in Latch-Up immunity

description

The TLC272 and TLC277 precision dual operational amplifiers combine a wide range of input offset voltage grades with low offset voltage drift, high input impedance, low noise, and speeds approaching that of general-purpose BiFET devices.

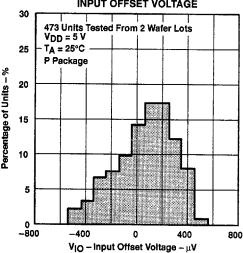
These devices use Texas instruments silicon-gate LinCMOS™ technology, which provides offset voltage stability far exceeding the stability available with conventional metal-gate processes.

The extremely high input impedance, low bias currents, and high slew rates make these costeffective devices ideal for applications which have previously been reserved for BiFET and NFET products. Four offset voltage grades are available (C-suffix and I-suffix types), ranging from the



NC - No internal connection

DISTRIBUTION OF TLC277 INPUT OFFSET VOLTAGE



low-cost TLC272 (10 mV) to the high-precision TLC277 (500 μ V). These advantages, in combination with good common-mode rejection and supply voltage rejection, make these devices a good choice for new state-of-the-art designs as well as for upgrading existing designs.

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PRODUCTION DATA information is current as of publication data. Products conform to specifications per the terms of Texas instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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AVAILABLE OPTIONS

			PAC	KAGED DEVIC	ES		CHIP
[™] A	V _{IO} max AT 25°C	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	TSSOP (PW)	FORM (Y)
0°C to 70°c	500 μV 2 mV 5 mV 10mV	TLC277CD TLC272BCD TLC272ACD TLC272CD		 	TLC277CP TLC272BCP TLC272ACP TLC272CP	 TLC272CPW	 TLC272Y
-40°C to 85°C	500 μV 2 mV 5 mV 10 mV	TLC277ID TLC272BID TLC272AID TLC272ID	- — — —	- - - -	TLC277IP TLC272BIP TLC272AIP TLC272IP	- - -	- - - -
-55°C to 125°C	500 μV 10 mV	TLC277MD TLC272MD	TLC277MFK TLC272MFK	TLC277MJG TLC272MJG	TLC277MP TLC272MP		_ _

The D package is available taped and reeled. Add R suffix to the device type (e.g., TLC277CDR).

description (continued)

In general, many features associated with bipolar technology are available on LinCMOSTM operational amplifiers without the power penalties of bipolar technology. General applications such as transducer interfacing, analog calculations, amplifier blocks, active filters, and signal buffering are easily designed with the TLC272 and TLC277. The devices also exhibit low voltage single-supply operation, making them ideally suited for remote and inaccessible battery-powered applications. The common-mode input voltage range includes the negative rail.

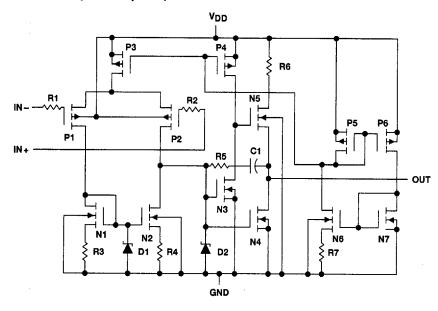
A wide range of packaging options is available, including small-outline and chip carrier versions for high-density system applications.

The device inputs and outputs are designed to withstand -100-mA surge currents without sustaining latch-up.

The TLC272 and TLC277 incorporate internal ESD-protection circuits that prevent functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2; however, care should be exercised in handling these devices as exposure to ESD may result in the degradation of the device parametric performance.

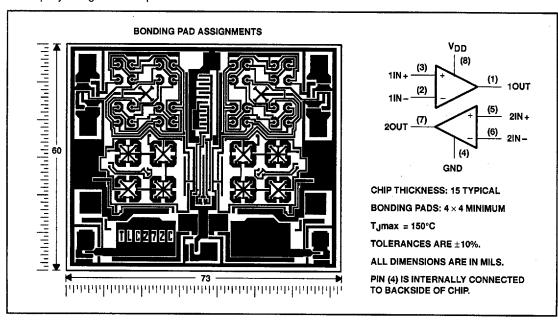
The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 85°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.

equivalent schematic (each amplifier)



TLC272Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC272C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{DD} (see Note 1)	18 V
Differential input voltage, V _{ID} (see Note 2)	±V _{DD}
Input voltage range, V _I (any input)	0.3 V to V _{DD}
Input current, I	±5 mA
output current, io (each output)	±30 mA
Total current into V _{DD}	45 mA
Total current out of GND	45 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Duration of short-circuit current at (of below) 25 C (see Note 5)	Con Dissinction Deting Toble
Continuous total dissipation	. See Dissipation Rating Table
Operating free-air temperature, T _A : C suffix	0°C to 70°C
Operating free-air temperature, T _A : C suffix	
Operating free-air temperature, T _A : C suffix	
Operating free-air temperature, T _A : C suffix	
Operating free-air temperature, T _A : C suffix I suffix M suffix Storage temperature range	
Operating free-air temperature, T _A : C suffix I suffix M suffix Storage temperature range Case temperature for 60 seconds: FK package	
Operating free-air temperature, T _A : C suffix I suffix M suffix Storage temperature range	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to network ground.

2. Differential voltages are at IN+ with respect to IN-.

 The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded (see application section).

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE TA = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	N/A
FK	1375 mW	11 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW	N/A
PW	525 mW	4.2 mW/°C	336 mW	N/A	N/A

recommended operating conditions

		C SUFFIX I SUFFIX M				M SU	FFIX	UNIT
	4	MIN	MAX	MIN	MAX	MIN	MAX	UNA
Supply voltage, VDD		3	16	4	16	4	16	٧
	V _{DD} = 5 V	-0.2	3.5	-0.2	3.5	0	3.5	
Common-mode input voltage, V _{IC}	V _{DD} = 10 V	-0.2	8.5	-0.2	8.5	0	8.5	
Operating free-air temperature, TA		0	70	-40	85	-55	125	ů

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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

	PARAMETER		TEST COND	ITIONS	TAT	TLC272 TLC272			UNIT
						MIN	TYP	MAX	L
		TLC272C	V _O = 1.4 V,	V ₁ C = 0,	25°C		1.1	10	
ļ		1202720	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			12	
Ì		TLC272AC	V _O = 1.4 V,	VIC = 0,	25°C		0.9	5	mV
۷ _{IO}	Input offset voltage	TLOZIZAC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			6.5	
110	input onset voltage	TLC272BC	V _O = 1.4 V,	V _{IC} = 0,	25°C		230	2000	
Ī		16027200	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			3000	
		TLC277C	VO = 1.4 V,	V _{IC} = 0,	25°C		200	500	μV
		1102770	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			1500	
ανιο	Temperature coefficient of input of	offset voltage			25°C to		1.8		μV/°C
₩VIO	Tomporataro coomoione or inpar	moot voltage			70°C		1.0		μν/ Ο
io	Input offset current (see Note 4)		V _O = 2.5 V,	V _{IC} = 2.5 V	25°C		0.1		pА
10	,		1.0 = 0 1,	710 - 2.0 7	70°C		7	300	p/\
Iв	Input bias current (see Note 4)		V _O = 2.5 V,	V _{IC} = 2.5 V	25°C		0.6		рА
טוי	(000 11010 1)		.0-2.0 .,	VIC - 2.0 V	70°C		40	600	þΛ
						-0.2	-0.3		
	Common made input voltage roa	**	İ		25°C	to 4	to 4.2		٧
VICR	Common-mode input voltage ran (see Note 5)	ge]			-0.2	7.2		
	,				Full range	to			V
						3.5			
					25°C	3.2	3.8		
VOH	High-level output voltage		V _{ID} = 100 mV,	$R_L = 10 \text{ k}\Omega$	0°C	3	3.8		V
					70°C	3	3.8		
					25°C		0	50	
VOL	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	0°C		0	50	mV
	,				70°C		0	50	
					25°C	5	23		
AVD	Large-signal differential voltage a	mplification	$V_O = 0.25 \text{ V to 2 V},$	$R_L = 10 \text{ k}\Omega$	0°C	4	27		V/mV
					70°C	4	20		
					25°C	65	80		
CMRR	Common-mode rejection ratio		V _{IC} = V _{ICR} min		0°C	60	84		dB
					70°C	60	85		
					25°C	65	95		
ksvr	Supply-voltage rejection ratio $(\Delta V_{DD}/\Delta V_{IO})$		V _{DD} = 5 V to 10 V,	V _O = 1.4 V	0°C	60	94		dB
	(21U)/21(U)			-	70°C	60	96		
					25°C		1.4	3.2	
IDD	Supply current (two amplifiers)		V _O = 2.5 V,	$V_{IC} = 5 V$,	0°C		1.6	3.6	mA
			No load		70°C		1.2	2.6	

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

	PARAMETER		TEST CONDI	TIONS	T _A †	TLC272 TLC272			UNIT
					,,	MIN	TYP	MAX	
		TI 00700	V _O = 1.4 V,	V _{IC} = 0,	25°C		1.1	10	
		TLC272C	$R_S = 50 \Omega$,	R _L = 10 kΩ	Full range			12	mV
		TI 007040	V _O = 1.4 V,	V _{IC} = 0,	25°C		0.9	5	111.4
		TLC272AC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			6.5	
۷ _{IO}	Input offset voltage	TI COTODO	VO = 1.4 V,	V _{IC} = 0,	25°C		290	2000	
		TLC272BC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			3000	μV
		TI 00770	VO = 1.4 V,	VIC = 0,	25°C		250	800	μν
		TLC277C	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			1900	
ανιο	Temperature coefficient of input of	offset voltage			25°C to 70°C		2		μV/°C
			V 5V	V- 5V	25°C		0.1		pΑ
ΙΟ	Input offset current (see Note 4)		$V_O = 5 V$,	V _{IC} = 5 V	70°C		7	300	¥
			V 6V	V- EV	25°C		0.7		pA
IВ	Input bias current (see Note 4)		V _O = 5 V,	V ₁ C = 5 V	70°C		50	600	μζ
						-0.2	-0.3		
					25°C	to g	to 9.2		V
VICR	Common-mode input voltage rar (see Note 5)	ige				-0.2	9.2		
,	(See Note 5)				Full range	-0.2 to			V
						8.5			
					25°C	8	8.5		
VOH	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	0°C	7.8	8.5		٧
					70°C	7.8	8.4		
		,			25°C		0	50	
VOL	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	IOL = 0	0°C		0	50	mV
					70°C		0	50	
					25°C	10	36		
AVD	Large-signal differential voltage a	amplification	$V_O = 1 \text{ V to 6 V},$	$R_L = 10 \text{ k}\Omega$	0°C	7.5	42		V/mV
					70°C	7.5	32		
					25°C	65	85		
CMRR	Common-mode rejection ratio		V _{IC} = V _{ICR} min		0°C	60	88		dB
					70°C	60	88		
					25°C	65	95		
ksvr	Supply-voltage rejection ratio (ΔVDD/ΔVIO)		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	$V_0 = 1.4 \text{ V}$	0°C	60	94		dΒ
	(4 A D D 1 A A D D 1				70°C	60	96		
			V- 05V	V- 5V	25°C		1.9	4	
IDD	Supply current (two amplifiers)		V _O = 2.5 V, No load	VIC = 5 V,	0°C		2.3	4.4	mA
					70°C		1.6	3.4	

† Full range is 0°C to 70°C.

NOTES: 4.. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

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electrical characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

	PARAMETER		TEST COND	ITIONS	τ _A †		21, TLC2 2B1, TL		UNIT
<u> </u>	TLC2					MiN	TYP	MAX	j
		TLC272I	$V_0 = 1.4 V$,	$V_{IC} = 0$,	25°C		1.1	10	
		1202721	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			13	m\/
		TLC272AI	V _O = 1.4 V,	V _{IC} = 0,	25°C		0.9	5	mV
VIO	Input offset voltage	120272711	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			7	
		TLC272BI	$V_O = 1.4 \text{ V},$	$V_{iC} = 0$,	25°C		230	2000	
1		72027231	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			3500	
		TLC2771	V _O = 1.4 V,	$V_{IC} = 0$,	25°C		200	500	μV
<u> </u>			$R_S = 50 \Omega$,	R _L = 10 kΩ	Full range			2000	
ανιο	Temperature coefficient of input	t offset voltage			25°C to 85°C		1.8		μV/°C
10	Input offset current (see Note 4	`	V _O = 2.5 V,	V _{IC} = 2.5 V	25°C		0.1		
110	input oncot outront (see Note 4	,	V() = 2.5 V,	AIC = 5.9 A	85°C		24	15	ρA
lΒ	Input bias current (see Note 4)		Vo - 25 V	V:- 05V	25°C		0.6		
פוי	input bias current (see Note 4)		V _O = 2.5 V _i	V _{IC} = 2.5 V	85°C		200	35	pΑ
						-0.2	-0.3		
					25°C	to	to		V
VICR	Common-mode input voltage ra (see Note 5)	inge				4	4.2		
	(200 14010 3)		<u> </u>		Full range	-0.2			v
					runrange	to 3.5			٧
					25°C	3.2	3.8	-	
٧он	High-level output voltage		V _{ID} = 100 mV,	$R_L = 10 k\Omega$	-40°C	3	3.8		V
				_	85°C	3	3.8		
					25°C		0	50	
v_{OL}	Low-level output voltage		V _{ID} = -100 mV,	iOL = 0	-40°C		0	50	mV
					85°C		0	50	
					25°C	5	23		
AVD	Large-signal differential voltage	amplification	V _O = 1 V to 6 V,	$R_L = 10 \text{ k}\Omega$	-40°C	3.5	32		V/mV
				_	85°C	3.5	19		
					25°C	65	80	\dashv	
CMRR	Common-mode rejection ratio		VIC = VICRMIN		-40°C	60	81	-	dB
					85°C	60	86		
	_				25°C	65	95	 	
ksvr	Supply-voltage rejection ratio		V _{DD} = 5 V to 10 V,	VO = 1.4 V	-40°C	60	92		dB
	(ΔVDD/ΔVIO)			. •	85°C	60	96		
		"			25°C		1.4	3.2	
IDD	Supply current (two amplifiers)		V _O = 5 V, No ioad	$V_{IC} = 5 V$	-40°C		1.9	4.4	mA
			IND IOAU		85°C		1.1	2.4	

†Full range is -40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

	PARAMETER		TEST CONDI	TIONS	TAT		21, TLC2 2B1, TLC		UNIT
						MIN	TYP	MAX	
		TI 00701	VO = 1.4 V,	V _{IC} = 0,	25°C		1.1	10	
		TLC2721	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			13	m۷
		TI 007041	V _O = 1.4 V,	V _{IC} = 0,	25°C		0.9	5	1110
		TLC272AI	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			7	
VIO	Input offset voltage	TI 007001	VO = 1.4 V,	V _{IC} = 0,	25°C		290	2000	
		TLC272BI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			3500	μV
		TI 00771	V _O = 1.4 V,	V _{IC} = 0,	25°C		250	800	μν
		TLC2771	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			2900	
αγιο	Temperature coefficient of input	offset voltage			25°C to 85°C		2		μV/°C
			V- 5V	V E.V	25°C		0.1		pА
ار	Input offset current (see Note 4)		V _O = 5 V,	V _{IC} = 5 V	85°C		26	1000	PΛ
				V - EV	25°C		0.7		۰.۸
ΙВ	Input bias current (see Note 4)		V _O = 5 V,	V _{IC} = 5 V	85°C		220	2000	pΑ
						-0.2	-0.3		
İ					25°C	to	to		٧
VICR	Common-mode input voltage rai	nge				9	9.2		
1 TICK	(see Note 5)				Cull	-0.2			٧
					Full range	8.5			, v
					25°C	8	8.5		
VOH	High-level output voltage		V _{ID} = 100 mV,	$R_1 = 10 \text{ k}\Omega$	-40°C	7.8	8.5		V
1.04	riigir iotoi ompartoimge		,	_	85°C	7.8	8.5		
 					25°C	1	0	50	
VOL	Low-level output voltage		V _{ID} = -100 mV,	IOL = 0	-40°C		0	50	, mV
1.05				0.	85°C		0	50	
 					25°C	10	36		
AVD	Large-signal differential voltage	amplification	VO = 1 V to 6 V,	R _L = 10 kΩ	-40°C	7	46		V/mV
1.40				_	85°C	7	31		
					25°C	65	85		
CMRR	Common-mode rejection ratio		V _{IC} = V _{ICR} min		-40°C	60	87		dB
					85°C	60	88		
				·····	25°C	65	95		
ksvr	Supply-voltage rejection ratio		V _{DD} = 5 V to 10 V,	Vo = 1.4 V	-40°C	60	92		dB
חיסיין	(ΔVDD/ΔVIO)			J	85°C	60	96		
					25°C		1.4	4	
lDD	Supply current (two amplifiers)		$V_0 = 5 V$	$V_{IC} = 5 V$,	-40°C		2.8	5	mA
יים.	Dappin outlone (the ampinore)		No load		85°C		1.5	3.2	

† Full range is -40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

	PARAMETER		TEST COND	UTIONS	7.1	TLC27	2M, TLC	277M	
,	FANAMEIEN		TEST COND	HIONS	TAT	MIN	TYP	MAX	UNIT
		TLC272M	V _O = 1.4 V,	V _{IC} = 0,	25°C		1.1	10	,,
VIO	Input offset voltage	TEOZIZIVI	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			12	mV
10	input onset voitage	TLC277M	V _O = 1.4 V,	V _{IC} = 0,	25°C		200	500	.,
		TEOZITIVI	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			3750	μV
ανιο	Temperature coefficient of input of voltage	offset			25°C to 125°C		2.1		μV/°C
10	Input offset current (see Note 4)		V _O = 2.5 V	V _{IC} = 2.5 V	25°C		0.1		pА
			70-2.0 1	VIC = 2.5 V	125°C		1.4	15	nA
lв	Input bias current (see Note 4)		V _O = 2.5 V	V _{IC} = 2.5 V	25°C		0.6		pΑ
	,		10 - 2.0 1	*IC = 2.0 *	125°C		9	35	nΑ
V	Common-mode input voltage ran	ge			25°C	0 to 4	-0.3 to 4.2		٧
VICR	(see Note 5)				Full range	0 to 3.5			٧
					25°C	3.2	3.8		
∨он	High-level output voltage	•	V _{ID} = 100 mV,	$R_L = 10 \text{ k}\Omega$	−55°C	3	3.8		٧
					125°C	3	3.8		
					25°C		0	50	
VOL	Low-level output voltage		V _{ID} = -100 mV,	IOL = 0	-55°C		0	50	m۷
					125°C		0	50	
					25°C	5	23		
AVD	Large-signal differential voltage a	mplification	$V_O = 0.25 \text{ V to 2 V}$	$R_L = 10 \text{ k}\Omega$	-55°C	3.5	35		V/mV
			- 100		125°C	3.5	16		
	_				25°C	65	80		
CMRR	Common-mode rejection ratio		VIC = VICRmin		−55°C	60	81		dB
					125°C	60	84		
	Supply-voltage rejection ratio				25°C	65	95		
ksvr	(ΔVDD/ΔVIO)		$V_{DD} = 5 \text{ V to } 10 \text{ V,}$	$V_O = 1.4 \text{ V}$	-55°C	60	90		dB
				- · · · · · · · · · · · · · · · · · · ·	125°C	60	97		
_			V _O = 2.5 V,	V _{IC} = 2.5 V,	25°C		1.4	3.2	
IDD	Supply current (two amplifiers)		ν() = 2.5 ν, No load	VIC = 2.5 V,	-55°C		2	5	mA
					125°C		1	2.2	

† Full range is -55°C to 125°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

					T.+	TLC27	M, TLC	277M	UNIT
	PARAMETER		TEST COND	HIONS	TAT	MIN	TYP	MAX	OIIII
			V _O = 1.4 V _i	V _{IC} = 0,	25°C		1.1	10	m۷
		TLC272M	R _S = 50 Ω,	$R_L = 10 \text{ k}\Omega$	Full range			12	1110
VIO	Input offset voltage		V _O = 1.4 V,	V _{IC} = 0,	25°C		250	800	μV
		TLC277M	$R_S = 50 \Omega$	$R_L = 10 \text{ k}\Omega$	Full range			4300	μν
ανιο	Temperature coefficient of inpurvoltage	t offset			25°C to 125°C		2.2		μV/°C
			V. 511	Via EV	25°C		0.1		pА
10	Input offset current (see Note 4	•)	V _O = 5 V,	VIC = 5 V	125°C		1.8	15	nA
)(. F)(Via EV	25°C		0.7		pΑ
lВ	Input bias current (see Note 4)		V _O = 5 V,	V _{IC} = 5 V	125°C		10	35	nA
	Common-mode input voltage ra	ange			25°C	0 to 9	-0.3 to 9.2		٧
VICR	(see Note 5)				Full range	0 to 8.5			٧
-					25°C	8	8.5		
Vон	High-level output voltage		V _{ID} = 100 mV,	RL = 10 kΩ	-55°C	7.8	8.5		٧
011	•				125°C	7.8	8.4		
					25°C		0	50	
VOL	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	IOL = 0	-55°C		0	50	mV
02			1		125°C		0	50	
					25°C	10	36		
AVD	Large-signal differential voltage	•	V _O = 1 V to 6 V,	$R_L = 10 \text{ k}\Omega$	-55°C	7	50		V/mV
	amplification		<u> </u>		125°C	7	27		
					25°C	65	85		
CMRR	Common-mode rejection ratio		V _{IC} = V _{ICR} min		−55°C	60	87		dB
					125°C	60	86		
					25°C	65	95		
ksvr	Supply-voltage rejection ratio		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	$V_{Q} = 1.4 \text{ V}$	-55°C	60	90		dB
	(ΔV _{DD} /ΔV _{IO})				125°C	60	97		
	· · · · · · · · · · · · · · · · · · ·				25°C		1.9	4	
IDD	Supply current (two amplifiers)		V _O = 5 V, No load	$V_{IC} = 5 V$	-55°C		3	6	mA
			140 1000		125°C		1.3	2.8	

† Full range is -55°C to 125°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

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electrical characteristics, $V_{DD} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

]	PARAMETER	TEST CON	DITIONS	T	LC272Y		11117
	CAINMEITH	TEST CON	DITIONS	MIN	TYP	MAX	UNIT
VIO	Input offset voltage	$V_O = 1.4 \text{ V},$ Rs = 50 Ω ,	$V_{IC} = 0$, $R_L = 10 \text{ k}\Omega$		1.1	10	mV
α_{VIO}	Temperature coefficient of input offset voltage				1.8		μV/°C
<u>0</u>	Input offset current (see Note 4)	V _O = 2.5 V,	V _{IC} = 2.5 V		0.1		pΑ
lв	Input bias current (see Note 4)	$V_{O} = 2.5 V$,	V _{IC} = 2.5 V		0.6		pΑ
VICR	Common-mode input voltage range (see Note 5)			-0.2 to 4	-0.3 to 4.2		٧
۷ОН	High-level output voltage	V _{ID} = 100 mV,	R _L = 10 kΩ	3.2	3.8		٧
VOL	Low-level output voltage	V _{ID} = -100 mV,	IOL = 0		0	50	m∨
AVD	Large-signal differential voltage amplification	V _O = 0.25 V to 2 V	R _L = 10 kΩ	5	23		V/mV
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min		65	80		dB
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V,	V _O = 1.4 V	65	95		dB
IDD	Supply current (two amplifiers)	V _O = 2.5 V, No load	V _{IC} = 2.5 V,		1.4	3.2	mA

electrical characteristics, V_{DD} = 10 V, T_A = 25°C (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	Ĩ	LC272Y		
	171 MAN ELL	TEST COM		MIN	TYP	MAX	UNIT
VIO	Input offset voltage	$V_O = 1.4 \text{ V},$ Rs = 50 Ω ,	V _{IC} = 0, R _L = 10 kΩ		1.1	10	mV
ανιο	Temperature coefficient of input offset voltage				1.8		μV/°C
10	Input offset current (see Note 4)	V _O = 5 V,	V _{IC} = 5 V	1	0.1		pА
lΒ	Input bias current (see Note 4)	V _O = 5 V,	V _{IC} = 5 V		0.7		pА
VICR	Common-mode input voltage range (see Note 5)	Ĺ	-	-0.2 to 9	-0.3 to 9.2		٧
۷он	High-level output voltage	V _{ID} = 100 mV,	$R_L = 10 \text{ k}\Omega$	8	8.5		V
VOL	Low-level output voltage	$V_{ID} = -100 \text{ mV},$	1 _{OL} = 0	1	0	50	mV
AVD	Large-signal differential voltage amplification	$V_{O} = 1 \text{ V to 6 V},$	$R_L = 10 \text{ k}\Omega$	10	36		V/mV
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min		65	85		dB
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	65	95		₫B
lDD	Supply current (two amplifiers)	V _O = 5 V, No load	V _{IC} = 5 V,		1.9	4	mA

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	PARAMETER	TEST CO	NDITIONS	TA	TLC272C, TLC272AC, TLC272BC, TLC277C		UNIT					
	CATACIVIE CELL				TLG272BC, TLG MIN TYP 3.6 4 3 2.9 3.1 2.5 25 320 340 260 1.7	MAX						
				25°C		3.6						
		ŀ	V _{IPP} = 1 V	0°C		4						
			$R_L = 10 \text{ k}\Omega$,	70°C		3		V/μs				
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1		25°C		2.9		V/μS				
		Coo , iguio .	V _{IPP} = 2.5 V	0°C		3.1						
					70°C		2.5					
Vn	Equivalent input noise voltage	f = 1 kHz, See Figure 2	R _S = 20 Ω,	25°C		25		nV/√Hz				
				25°C		320						
ВОМ	Maximum output-swing bandwidth	VO = VOH,	CL = 20 pF,	0°C		340		kHz				
- O IVI		R _L = 10 kΩ, See Fig	HL = 10 K32,	See Figure 1	RL = 10 K2, See Figure	70°C		260				
				25°C		1.7						
B ₁	Unity-gain bandwidth	V ₁ = 10 mV,	$C_L = 20 pF$,	0°C		2		MHz				
-1		See Figure 3	See Figure 3	See Figure 3	See Figure 3	3	See Figure 3	70°C		1.3		
			$V_{\parallel} = 10 \text{ mV}, f = B_{1},$ $C_{L} = 20 \text{ pF}, \text{See Figure}$		25°C		46°					
φm	Phase margin				0°C		47°]			
''''		or = 50 br.	See Figure 3	70°C		43°]				

operating characteristics at specified free-air temperature, V_{DD} = 10 V

	PARAMETER	TEST CONDITIONS		TA				UNIT				
	. A. Z. M. Z. Z.				TLC272C, TLC372BC, TLC471LC272BC, TLC471LC27BC, TLC471	MAX						
				25°C		5.3						
			V _{IPP} = 1 V	0°C		5.9	5.9					
		$R_L = 10 \text{ k}\Omega$		70°C		4.3		V/μs				
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1		25°C		4.6		V/μS				
			0°C		5.1							
						70°C		3.8				
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	R _S = 20 Ω,	25°C		25		nV/√Hz				
				25°C		200						
Вом	Maximum output-swing bandwidth	Vo = VoH,	Vo = VoH,	C _L = 20 pF, See Figure 1	0°C		220		kHz			
""		m[= 10 K22,	See Figure 1	70°C		140						
				25°C		2.2						
B ₁	Unity-gain bandwidth	V _I = 10 mV,	C _L = 20 pF,	0°C		2.5		MHz				
'	See Figure 3	See Figure 3	See rigure 3		70°C		1.8					
		V _I = 10 mV, f = B ₁ ,	V _I = 10 mV, f = B	V _I = 10 mV, f = B ₁ ,	V _I = 10 mV, f	$V_{\parallel} = 10 \text{ mV}, f = B_{1},$ Phase margin $C_{\parallel} = 20 \text{ pF}$ See Figure		25°C		49°		
φm	Phase margin						V _I = 10 mV, C _L = 20 pF,	V _I = 10 mV,	f = B ₁ , See Figure 3	0°C		50°
''''		CL = 20 pr ,	CCC i iguile o	70°C		46°						

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operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	PARAMETER	TEST CO	NDITIONS	TA	TLC272	21, TLC2 281, TLC		UNIT		
					MIN	TYP	MAX			
				25°C		3.6				
ļ	,		V _I PP = 1 V	-40°C		4.5				
SR	Slew rate at unity gain	$R_L = 10 \text{ k}\Omega$, $C_L = 20 \text{ pF}$,		85°C		2.8		Min		
"	Olew rate at unity gain	See Figure 1		25°C		2.9		V/μs		
			V _{IPP} = 2.5 V	-40°C		3.5				
						85°C		2.3		1
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C		25		nV/√Hz		
					25°C		320			
Вом	Maximum output-swing bandwidth	$V_O = V_{OH}$, $R_i = 10 \text{ k}\Omega$,	Cլ = 20 pF, See Figure 1	-40°C		380		kHz		
		11E - 10 Kaz,	Cee i igule i	85°C		250				
				25°C		1.7				
B ₁	Unity-gain bandwidth	V _I = 10 mV, See Figure 3	C _L = 20 pF,	-40°C		2.6		MHz		
		Obe Figure 5		85°C		1.2				
)/ 10 m)/		25°C		46°				
φm	Phase margin		f = B ₁ , See Figure 3	-40°C		49°				
· 			Gee i igure o	85°C		43°				

operating characteristics at specified free-air temperature, V_{DD} = 10 V

	PARAMETER	TEST CO	NDITIONS	TA	TLC272I, TLC TLC272BI, TL		UNIT		
			·		MIN TYP	MAX	1		
				25°C	5.3				
			V _{[PP} = 1 V	-40°C	6.8				
SR	Slew rate at unity gain	$R_L = 10 \text{ k}\Omega$, $C_L = 20 \text{ pF}$,		85°C	4		N//		
On t	Glew rate at unity gain	See Figure 1		25°C	4.6		V/µs		
			V _I PP = 5.5 V	-40°C	5.8				
			85°C	3.5		1			
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	25		nV/√Hz		
	Maximum output-swing bandwidth		C _L = 20 pF, See Figure 1	25°C	200				
BOM		VO = VOH, RL = 10 kΩ,		-40°C	260		kHz		
		N_ = 10 K22,		85°C	130				
				25°C	2.2				
B ₁	Unity-gain bandwidth	V _I = 10 mV, See Figure 3	Cլ = 20 pF,	-40°C	3.1		MHz		
	366 rigule 3		85°C	1.7					
	·	V 40	. 5	25°C	49°				
φm	Phase margin	Phase margin	$V_{\parallel} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$		$V_1 = 10 \text{ mV}, f = B_1,$ $C_1 = 20 \text{ pc} \text{See Figure 2}$	-40°C	52°		
		OL = 20 pr, See Figure 3		85°C	46°				

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operating characteristics at specified free-air temperature, V_{DD} = 5 V

				_	TLC27	2M, TLC	277M	UNIT		
	PARAMETER	TEST CO	NDITIONS	TA	3.6 4.7 2.3 2.9 3.7 2 25 320 400 230	TYP	MAX	UKII		
				25°C		3.6				
				V _{IPP} = 1 V	-55°C		4.7			
		$R_L = 10 kΩ$,		125°C		2.3		V/μs		
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1		25°C		2.9		V/μS		
			V _{IPP} = 2.5 V	-55°C		3.7				
			I I "' ⊢	125°C		2				
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	R _S = 20 Ω,	25°C		25		лV/√Hz		
	Maximum output-swing bandwidth			25°C		320				
ВОМ		Maximum output-swing bandwidth VO = VOI	Maximum output-swing bandwidth VO = VOH,	VO = VOH,	CL = 20 pF,	−55°C		400		kHz
0	, -	$R_L = 10 \text{ k}\Omega$	See Figure 1	125°C		230				
<u> </u>				25°C		1.7				
B ₁		V _j = 10 mV,	$C_L = 20 pF$,	-55°C		2.9		MHz		
'		See Figure 3	See Figure 3		125°C		1.1			
				25°C		46°				
φm	Phase margin	Phase margin	V _I = 10 mV,		f = B ₁ , See Figure 3	−55°C		49°		
``''		C _L = 20 pF, See	See Figure 3	125°C		41°		<u> </u>		

operating characteristics at specified free-air temperature, V_{DD} = 10 V

		TF07 00	NDITIONS	-	TLC27	2M, TLC	277M	UNIT			
	PARAMETER	IESI CO	NDITIONS	TA	MIN	TYP	MAX	ONII			
				25°C		5.3					
ļ			V _{IPP} = 1 V	−55°C		7.1					
SR		R _L = 10 kΩ,		.	125°C		3.1		V/μs		
	Slew rate at unity gain	C _L = 20 pF, See Figure 1		25°C		4.6		V/μS			
		CCC Igano	V _{IPP} = 5.5 V	-55°C		6.1					
			125°C		2.7						
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	R _S = 20 Ω,	25°C		25		nV/√Hz			
— —					25°C		200				
ВОМ	Maximum output-swing bandwidth			-55°C		280		kHz			
""		ML = 10 K32,		125°C		110					
	And the second s			25°C		2.2					
B ₁	Unity-gain bandwidth	I See Figure 3	-55°C		3.4		MHz				
'	See rigure 3		See Figure 3	Gee rigule 3	125°C		1.6				
				25°C		49°					
φm	Phase margin		V _I = 10 mV, f = B ₁	V _I = 10 mV,	V _I = 10 mV,	f = B ₁ , See Figure 3	−55°C		52°		
	-	OL = 20 pr, See Figure		GL = 20 pr, See Figure 3		125°C		44°			

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operating characteristics, $V_{DD} = 5 V$, $T_A = 25$ °C

	PARAMETER	7	TEST CONDITIONS			TLC272Y		
			ZOT COMDITIC	,NS	MIN	TYP	MAX	UNIT
SR	Slew rate at unity gain	$R_L = 10 \text{ k}\Omega$	C _L = 20 pF,	V _{IPP} = 1 V		3.6		VII -
		See Figure 1		V _{IPP} = 2.5 V	2.9		V/μs	
٧n	Equivalent input noise voltage	f = 1 kHz,	R _S = 20 Ω,	See Figure 2		25		nV/√Hz
ВОМ	Maximum output-swing bandwidth	V _O = V _{OH} , See Figure 1	C _L = 20 pF,	R _L = 10 kΩ,		320		kHz
B ₁	Unity-gain bandwidth	V _I = 10 mV,	C _L = 20 pF,	See Figure 3		1.7		MHz
φm	Phase margin	V _I = 10 mV, See Figure 3	f = B ₁ ,	C _L = 20 pF,		46°		

operating characteristics, V_{DD} = 10 V, T_A = 25°C

	PARAMETER	T	TEST CONDITIONS			TLC272Y		
		'	EST CONDITIC	7145	MIN TYP	MAX	UNIT	
SR	Slew rate at unity gain	$R_L = 10 \text{ k}\Omega$	C _L = 20 pF,	V _{IPP} = 1 V	5.3	3	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
• • • • • • • • • • • • • • • • • • • •	cion rate at army gain	See Figure 1		V _i pp = 5.5 V	4.€		V/μs	
٧n	Equivalent input noise voltage	f = 1 kHz,	R _S = 20 Ω,	See Figure 2	25	,	nV/√Hz	
ВОМ	Maximum output-swing bandwidth	VO = VOH, See Figure 1	C _L = 20 pF,	R _L = 10 kΩ,	200		kHz	
B ₁	Unity-gain bandwidth	$V_i = 10 \text{ mV},$	C _L = 20 pF,	See Figure 3	2.2		MHz	
φm	Phase margin	V _I = 10 mV, See Figure 3	f = B ₁ ,	C _L = 20 pF,	499			

PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

Because the TLC272 and TLC277 are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

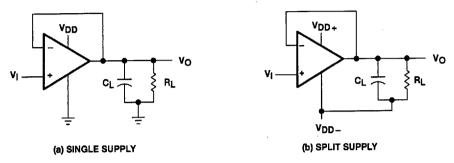


Figure 1. Unity-Gain Amplifier

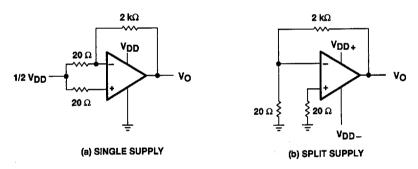


Figure 2. Noise-Test Circuit

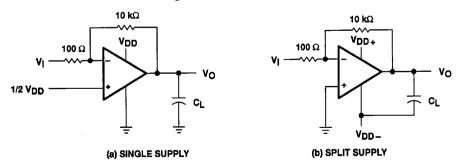


Figure 3. Gain-of-100 Inverting Amplifier

PARAMETER MEASUREMENT INFORMATION

input bias current

Because of the high input impedance of the TLC272 and TLC277 operational amplifiers, attempts to measure the input bias current can result in erroneous readings. The bias current at normal room ambient temperature is typically less than 1 pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

- Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 4). Leakages that would otherwise flow to the inputs are shunted away.
- Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the open-socket leakage readings from the readings obtained with a device in the test socket.

One word of caution: many automatic testers as well as some bench-top operational amplifier testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into the test socket to obtain a correct reading; therefore, an open-socket reading is not feasible using this method.

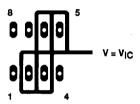


Figure 4. Isolation Metal Around Device Inputs (JG and P packages)

low-level output voltage

To obtain low-supply-voltage operation, some compromise was necessary in the input stage. This compromise results in the device low-level output being dependent on both the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions should be observed. If conditions other than these are to be used, please refer to Figures 14 through 19 in the Typical Characteristics of this data sheet.

input offset voltage temperature coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture results in leakage and contact resistance, which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal itself, thereby rendering it useless. It is suggested that these measurements be performed at temperatures above freezing to minimize error.

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PARAMETER MEASUREMENT INFORMATION

full-power response

Full-power response, the frequency above which the operational amplifier slew rate limits the output voltage swing, is often specified two ways: full-linear response and full-peak response. The full-linear response is generally measured by monitoring the distortion level of the output while increasing the frequency of a sinusoidal input signal until the maximum frequency is found above which the output contains significant distortion. The full-peak response is defined as the maximum output frequency, without regard to distortion, above which full peak-to-peak output swing cannot be maintained.

Because there is no industry-wide accepted value for significant distortion, the full-peak response is specified in this data sheet and is measured using the circuit of Figure 1. The initial setup involves the use of a sinusoidal input to determine the maximum peak-to-peak output of the device (the amplitude of the sinusoidal wave is increased until clipping occurs). The sinusoidal wave is then replaced with a square wave of the same amplitude. The frequency is then increased until the maximum peak-to-peak output can no longer be maintained (Figure 5). A square wave is used to allow a more accurate determination of the point at which the maximum peak-to-peak output is reached.



Figure 5. Full-Power-Response Output Signal

test time

Inadequate test time is a frequent problem, especially when testing CMOS devices in a high-volume, short-test-time environment. Internal capacitances are inherently higher in CMOS than in bipolar and BiFET devices and require longer test times than their bipolar and BiFET counterparts. The problem becomes more pronounced with reduced supply levels and lower temperatures.

TLC272, TLC272A, TLC272B, TLC272Y, TLC277 Lincmos $^{\text{TM}}$ PRECISION DUAL OPERATIONAL AMPLIFIERS

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TYPICAL CHARACTERISTICS

Table of Graphs

		•	FIGURE
VIO	Input offset voltage	Distribution	6, 7
ανιο	Temperature coefficient of input offset voltage	Distribution	8, 9
VOH	High-level output voltage	vs High-level output current vs Supply voltage vs Free-air temperature	10, 11 12 13
VOL	Low-level output voltage	vs Common-mode input voltage vs Differential input voltage vs Free-air temperature vs Low-level output current	14, 15 16 17 18, 19
AVD	Large-signal differential voltage amplification	vs Supply voltage vs Free-air temperature vs Frequency	20 21 32, 33
IB	Input bias current	vs Free-air temperature	22
110	Input offset current	vs Free-air temperature	22
ViC	Common-mode input voltage	vs Supply voltage	23
DD	Supply current	vs Supply voltage vs Free-air temperature	24 25
SR	Slew rate	vs Supply voltage vs Free-air temperature	26 27
	Normalized slew rate	vs Free-air temperature	28
VO(PP)	Maximum peak-to-peak output voltage	vs Frequency	29
B ₁	Unity-gain bandwidth	vs Free-air temperature vs Supply voltage	30 31
Фm	Phase margin	vs Supply voltage vs Free-air temperature vs Load capacitance	34 35 36
٧n	Equivalent input noise voltage	vs Frequency	37
	Phase shift	vs Frequency	32, 33

TYPICAL CHARACTERISTICS

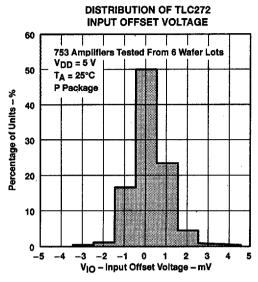


Figure 6

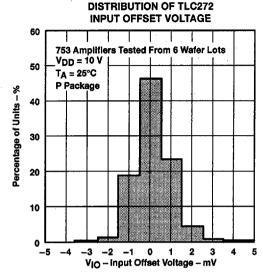


Figure 7

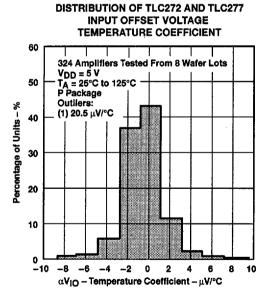
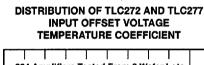


Figure 8



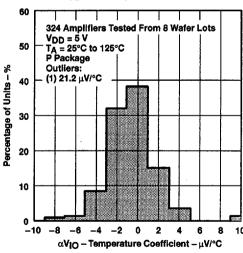
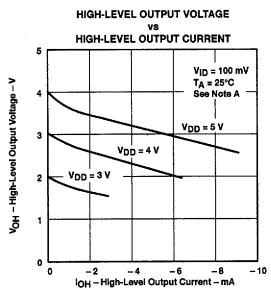


Figure 9

TYPICAL CHARACTERISTICS[†]



NOTE A: The 3-V curve only applies to the C version.

HIGH-LEVEL OUTPUT VOLTAGE **HIGH-LEVEL OUTPUT CURRENT** 16 $V_{ID} = 100 \text{ mV}$ 14 TA = 25°C VOH - High-Level Output Voltage - V V_{DD} = 16 V 12 10 8 V_{DD} = 10 V 6 4 2 0 0 -15 -20 - 25 - 30 IOH - High-Level Output Current - mA

Figure 10

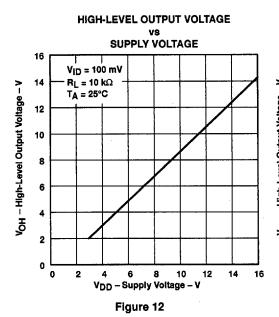


Figure 11

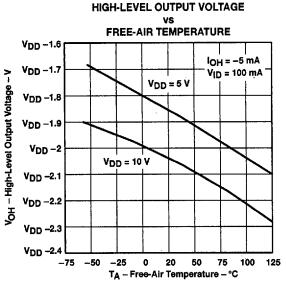


Figure 13

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS†

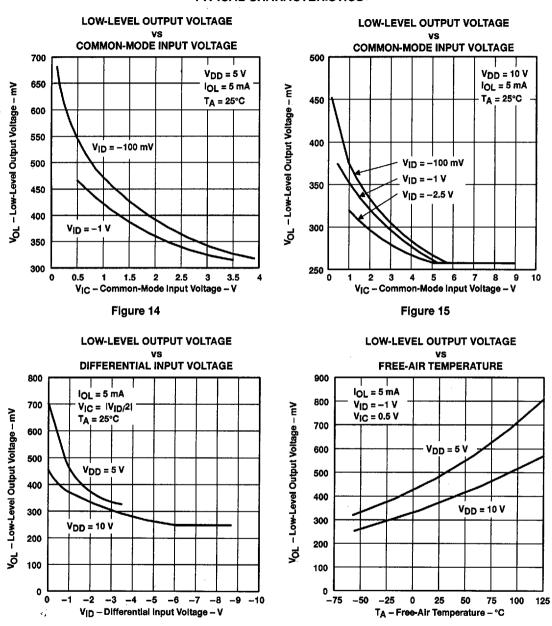


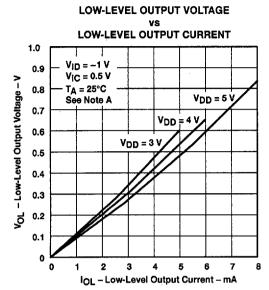
Figure 16

Figure 17

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

LOW-LEVEL OUTPUT VOLTAGE

TYPICAL CHARACTERISTICST



NOTE A: The 3-V curve only applies to the C version.

LOW-LEVEL OUTPUT CURRENT 3.0 $V_{ID} = -1 V$ VIC = 0.5 V - Low-Level Output Voltage - V 2.5 T_A = 25°C V_{DD} = 16 V₂ 2.0 V_{DD} = 10 V 1.5 1.0 Š 0.5 0 30 0 10 15 20 25 IOL - Low-Level Output Current - mA

LARGE-SIGNAL

Figure 18

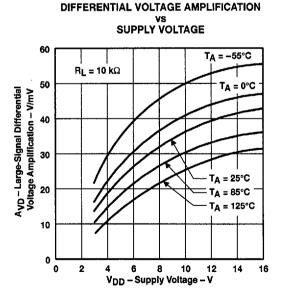
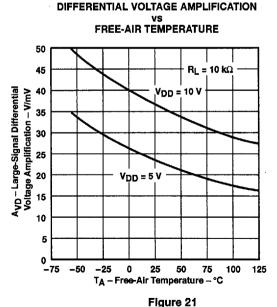


Figure 20

Figure 19

LARGE-SIGNAL



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICST

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT FREE-AIR TEMPERATURE 10000 IB and IIO - Input Bias and Offset Currents - pA V_{DD} = 10 V V_{IC} = 5 V See Note A 1000 100 ÌΟ 10 1 0.1 25 35 45 55 65 75 85 95 105 115 125

NOTE A: The typical values of input bias current and input

COMMON-MODE INPUT VOLTAGE POSITIVE LIMIT SUPPLY VOLTAGE 16 TA = 25°C V_{IC} - Common-Mode Input Voltage - V 14 12 10 8 6 2 0 0 2 8 10 12 16 14 V_{DD} - Supply Voltage - V

offset current below 5 pA were determined mathematically.

Figure 22

TA - Free-Air Temperature - °C

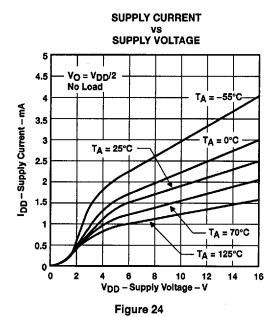


Figure 23

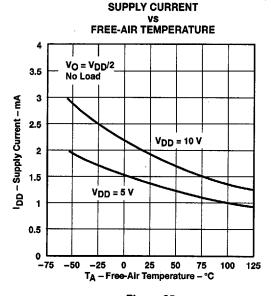


Figure 25

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

 $R_L = 10 \text{ k}\Omega$

See Figure 1

1000

f - Frequency - kHz Figure 29

2

10

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TYPICAL CHARACTERISTICS[†]

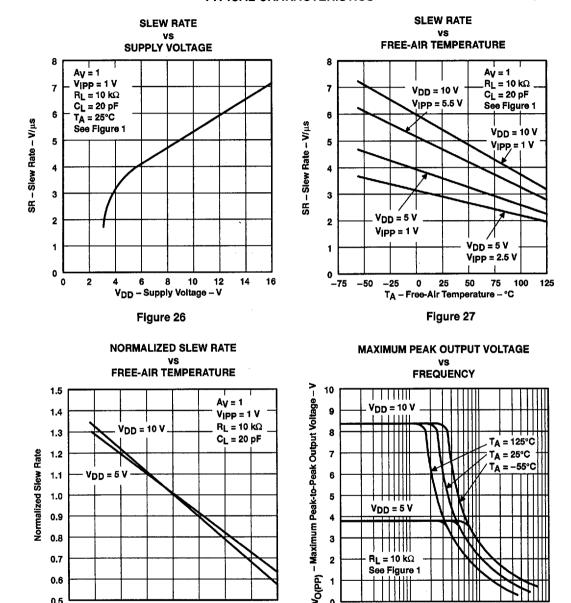


Figure 28

25 50 75 100

TA - Free-Air Temperature - °C

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



10000

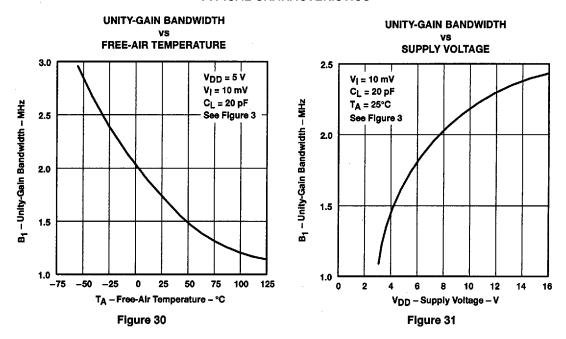
0.7

0.6 0.5

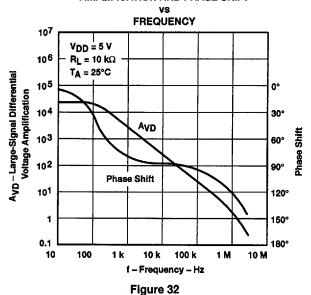
--50 **–75**

-25

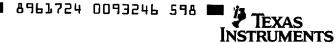
TYPICAL CHARACTERISTICS†



LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS†

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT

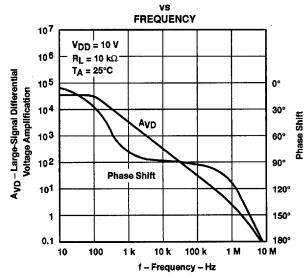
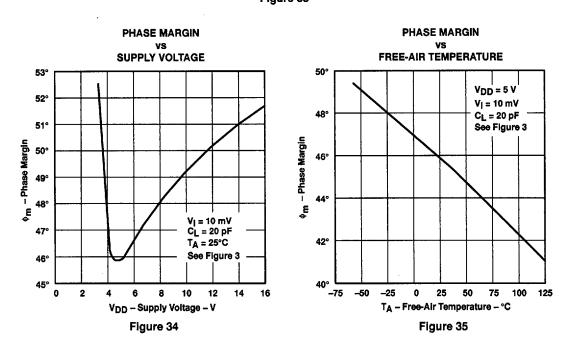


Figure 33

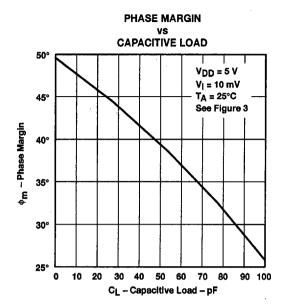


[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS



EQUIVALENT INPUT NOISE VOLTAGE V\$ FREQUENCY 400 V_n – Equivalent Input Noise Voltage –nV/ √Hz $V_{DD} = 5 V$ $R_S = 20 \Omega$ TA = 25°C 300 200 100 0 10 100 1000 f - Frequency - Hz

Figure 36

Figure 37

APPLICATION INFORMATION

single-supply operation

While the TLC272 and TLC277 perform well using dual power supplies (also called balanced or split supplies), the design is optimized for single-supply operation. This design includes an input common-mode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 3 V (C-suffix types), thus allowing operation with supply levels commonly available for TTL and HCMOS; however, for maximum dynamic range, 16-V single-supply operation is recommended.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. A resistive voltage divider is usually sufficient to establish this reference level (see Figure 38). The low input bias current of the TLC272 and TLC277 permits the use of very large resistive values to implement the voltage divider, thus minimizing power consumption.

The TLC272 and TLC277 work well in conjunction with digital logic; however, when powering both linear devices and digital logic from the same power supply, the following precautions are recommended:

- Power the linear devices from separate bypassed supply lines (see Figure 39); otherwise, the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic.
- 2. Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, high-frequency applications may require RC decoupling.

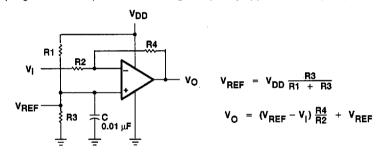


Figure 38. Inverting Amplifier With Voltage Reference

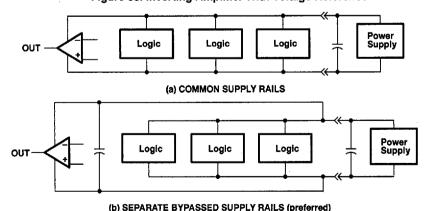


Figure 39. Common vs Separate Supply Rails



APPLICATION INFORMATION

input characteristics

The TLC272 and TLC277 are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. Note that the lower range limit includes the negative rail, while the upper range limit is specified at $V_{DD} - 1$ V at $T_A = 25$ °C and at $V_{DD} - 1.5$ V at all other temperatures.

The use of the polysilicon-gate process and the careful input circuit design gives the TLC272 and TLC277 very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically 0.1 μ V/month, including the first month of operation.

Because of the extremely high input impedance and resulting low bias current requirements, the TLC272 and TLC277 are well suited for low-level signal processing; however, leakage currents on printed-circuit boards and sockets can easily exceed bias current requirements and cause a degradation in device performance. It is good practice to include guard rings around inputs (similar to those of Figure 4 in the Parameter Measurement Information section). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 40).

Unused amplifiers should be connected as grounded unity-gain followers to avoid possible oscillation.

noise performance

The noise specifications in operational amplifier circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirements of the TLC272 and TLC277 result in a very low noise current, which is insignificant in most applications. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than 50 k Ω , since bipolar devices exhibit greater noise currents.

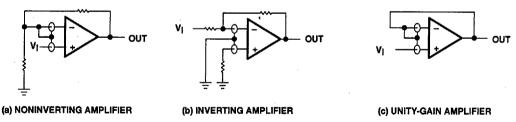


Figure 40. Guard-Ring Schemes

output characteristics

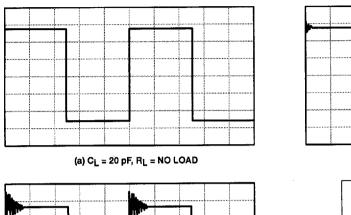
The output stage of the TLC272 and TLC277 is designed to sink and source relatively high amounts of current (see typical characteristics). If the output is subjected to a short-circuit condition, this high current capability can cause device damage under certain conditions. Output current capability increases with supply voltage.

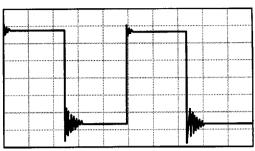
All operating characteristics of the TLC272 and TLC277 are measured using a 20-pF load. The devices can drive higher capacitive loads; however, as output load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation (see Figure 41). In many cases, adding a small amount of resistance in series with the load capacitance alleviates the problem.

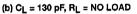


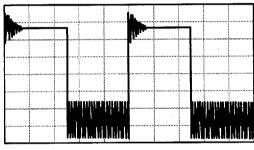
APPLICATION INFORMATION

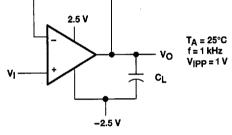
output characteristics (continued)











(c) CL = 150 pF, RL = NO LOAD

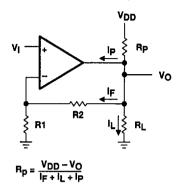
(d) TEST CIRCUIT

Figure 41. Effect of Capacitive Loads and Test Circuit

Although the TLC272 and TLC277 possess excellent high-level output voltage and current capability, methods for boosting this capability are available, if needed. The simplest method involves the use of a pullup resistor (Rp) connected from the output to the positive supply rail (see Figure 42). There are two disadvantages to the use of this circuit. First, the NMOS pulldown transistor N4 (see equivalent schematic) must sink a comparatively large amount of current. In this circuit, N4 behaves like a linear resistor with an on resistance between approximately $60~\Omega$ and $180~\Omega$, depending on how hard the operational amplifier input is driven. With very low values of Rp, a voltage offset from 0 V at the output occurs. Second, pullup resistor Rp acts as a drain load to N4 and the gain of the operational amplifier is reduced at output voltage levels where N5 is not supplying the output current.

APPLICATION INFORMATION

output characteristics (continued)



 I_p = Pullup current required by the operational amplifier (typically 500 μ A)

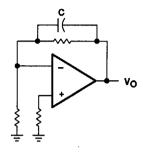


Figure 43. Compensation for Input Capacitance

Figure 42. Resistive Pullup to Increase VOH

feedback

Operational amplifier circuits almost always employ feedback, and since feedback is the first prerequisite for oscillation, some caution is appropriate. Most oscillation problems result from driving capacitive loads (discussed previously) and ignoring stray input capacitance. A small-value capacitor connected in parallel with the feedback resistor is an effective remedy (see Figure 43). The value of this capacitor is optimized empirically.

electrostatic discharge protection

The TLC272 and TLC277 incorporate an internal electrostatic discharge (ESD) protection circuit that prevents functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2. Care should be exercised, however, when handling these devices as exposure to ESD may result in the degradation of the device parametric performance. The protection circuit also causes the input bias currents to be temperature dependent and have the characteristics of a reverse-biased diode.

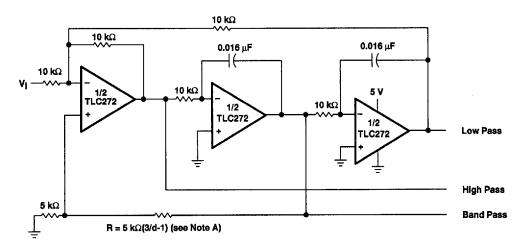
latch-up

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC272 and TLC277 inputs and outputs were designed to withstand -100-mA surge currents without sustaining latch-up; however, techniques should be used to reduce the chance of latch-up whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltage should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the positive supply rail and ground and can be triggered by surges on the supply lines and/or voltages on either the output or inputs that exceed the supply voltage. Once latch-up occurs, the current flow is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor and usually results in the destruction of the device. The chance of latch-up occurring increases with increasing temperature and supply voltages.



APPLICATION INFORMATION



NOTE A: d = damping factor, 1/Q

Figure 44. State-Variable Filter

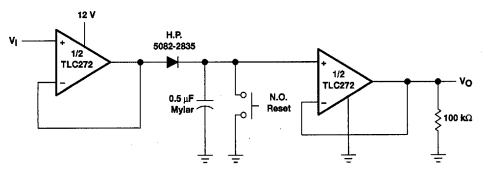
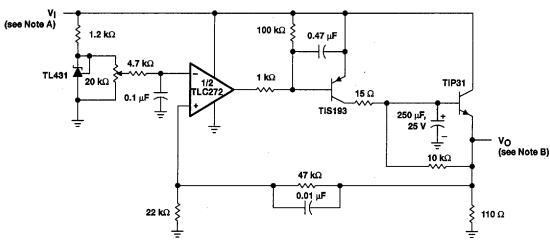


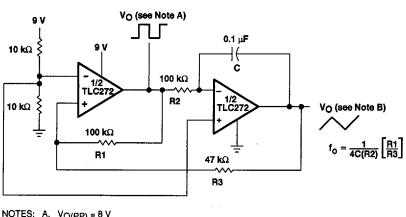
Figure 45. Positive-Peak Detector

APPLICATION INFORMATION



NOTES: A. $V_1 = 3.5 \text{ to } 15 \text{ V}$ B. $V_0 = 2 \text{ V}$, 0 to 1 A

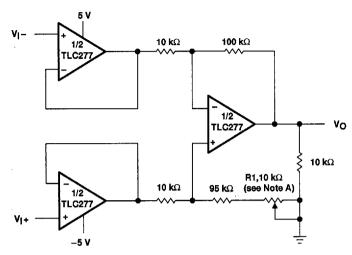
Figure 46. Logic-Array Power Supply



NOTES: A. $V_{O(PP)} = 8 V$ B. $V_{O(PP)} = 4 V$

Figure 47. Single-Supply Function Generator

APPLICATION INFORMATION



NOTE A: CMRR adjustment must be noninductive.

Figure 48. Low-Power Instrumentation Amplifier

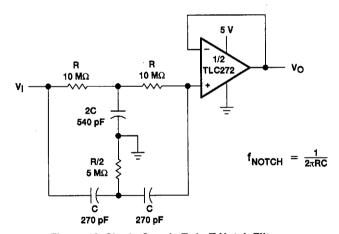


Figure 49. Single-Supply Twin-T Notch Filter